Search Notes

Applicati	on/Control No.	Applicant(s)/Patent Reexamination	under
10/723,7	29	BORTHAKUR ET A	AL.
Examine	•	Art Unit	
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SEARCHED				
Class	Subclass	Date	Examiner	
				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
invento seauch EAST attached SCM	Hayob	1		
test search class/sub 707/1-3,10,100,102, 200				
709/217, 224, 225				